

**STN1NC60****N-CHANNEL 600V - 12Ω - 0.3A - SOT-223  
PowerMesh™II MOSFET**

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STN1NC60	600 V	<15Ω	0.3 A

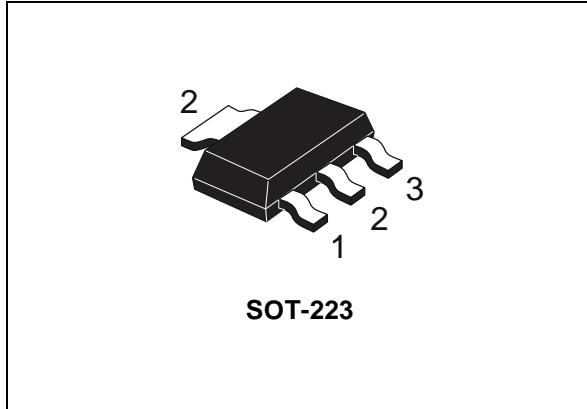
- TYPICAL R<sub>D(on)</sub> = 12Ω
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- NEW HIGH VOLTAGE BENCHMARK
- GATE CHARGE MINIMIZED

**DESCRIPTION**

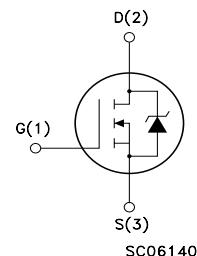
The PowerMESH™II is the evolution of the first generation of MESH OVERLAY™. The layout refinements introduced greatly improve the Ron\*area figure of merit while keeping the device at the leading edge for what concerns switching speed, gate charge and ruggedness.

**APPLICATIONS**

- AC ADAPTORS AND BATTERY CHARGERS
- SWITCH MODE POWER SUPPLIES (SMPS)



SOT-223

**INTERNAL SCHEMATIC DIAGRAM****ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	600	V
V <sub>DGR</sub>	Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)	600	V
V <sub>GS</sub>	Gate- source Voltage	±30	V
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 25°C	0.3	A
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 100°C	0.18	A
I <sub>DM</sub> <sup>(1)</sup>	Drain Current (pulsed)	1.2	A
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	2.5	W
	Derating Factor	0.02	W/°C
dv/dt	Peak Diode Recovery voltage slope	3	V/ns
T <sub>stg</sub>	Storage Temperature	-60 to 150	°C
T <sub>j</sub>	Max. Operating Junction Temperature	150	°C

(•)Pulse width limited by safe operating area

(1)I<sub>SD</sub> ≤ 0.3A, di/dt ≤ 100A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>j</sub> ≤ T<sub>JMAX</sub>

## STN1NC60

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### THERMAL DATA

Rthj-pcb Rthj-amb $T_J$	Thermal Resistance Junction-PC Board Thermal Resistance Junction-ambient Max (Surface Mounted) Maximum Lead Temperature For Soldering Purpose	50 60 260	$^{\circ}\text{C}/\text{W}$ $^{\circ}\text{C}/\text{W}$ $^{\circ}\text{C}$
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### AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
$I_{\text{AR}}$	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_J$ max)	0.3	A
$E_{\text{AS}}$	Single Pulse Avalanche Energy (starting $T_J = 25^{\circ}\text{C}$ , $I_D = I_{\text{AR}}$ , $V_{\text{DD}} = 50\text{ V}$ )	60	mJ

### ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED)

OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}$ , $V_{GS} = 0$	600			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating}, T_C = 125^{\circ}\text{C}$			1 50	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate-body Leakage Current ( $V_{DS} = 0$ )	$V_{GS} = \pm 30\text{V}$			$\pm 100$	nA

### ON (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	2	3	4	V
$R_{DS(\text{on})}$	Static Drain-source On Resistance	$V_{GS} = 10\text{V}$ , $I_D = 0.5\text{ A}$		12	15	$\Omega$
$I_{D(\text{on})}$	On State Drain Current	$V_{DS} > I_{D(\text{on})} \times R_{DS(\text{on})\text{max}}$ , $V_{GS} = 10\text{V}$	1			A

### DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$g_{fs}(1)$	Forward Transconductance	$V_{DS} > I_{D(\text{on})} \times R_{DS(\text{on})\text{max}}$ , $I_D = 0.5\text{A}$		0.87		S
$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0$		108		pF
$C_{oss}$	Output Capacitance			18		pF
$C_{rss}$	Reverse Transfer Capacitance			2.5		pF

## ELECTRICAL CHARACTERISTICS (CONTINUED)

## SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on Delay Time Rise Time	$V_{DD} = 300V$ , $I_D = 0.5A$ $R_G = 4.7\Omega$ $V_{GS} = 10V$ (see test circuit, Figure 3)		7.2 8		ns ns
$Q_g$	Total Gate Charge	$V_{DD} = 480V$ , $I_D = 1A$ ,		7.3	10	nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = 10V$		3.4		nC
$Q_{gd}$	Gate-Drain Charge			2.5		nC

## SWITCHING OFF

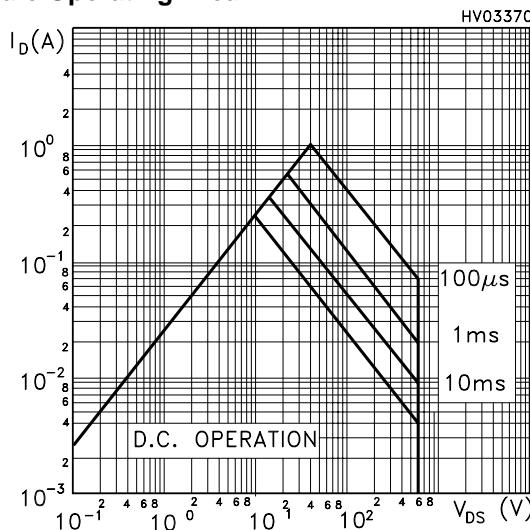
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{r(V_{off})}$	Off-voltage Rise Time	$V_{DD} = 480V$ , $I_D = 1A$ ,		33		ns
$t_f$	Fall Time	$R_G = 4.7\Omega$ , $V_{GS} = 10V$ (see test circuit, Figure 5)		11		ns
$t_c$	Cross-over Time			43		ns

## SOURCE DRAIN DIODE

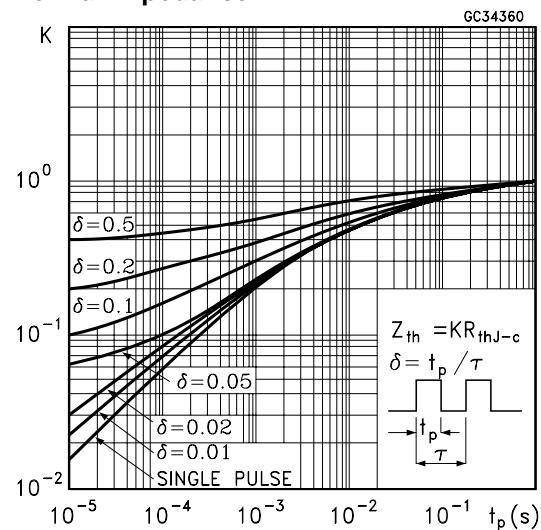
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain Current				0.3	A
$I_{SDM}$ (2)	Source-drain Current (pulsed)				1.2	A
$V_{SD}$ (1)	Forward On Voltage	$I_{SD} = 0.3 A$ , $V_{GS} = 0$			1.6	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 1A$ , $di/dt = 100A/\mu s$ ,		450		ns
$Q_{rr}$	Reverse Recovery Charge	$V_{DD} = 25V$ , $T_j = 150^\circ C$		720		$\mu C$
$I_{RRM}$	Reverse Recovery Current	(see test circuit, Figure 5)		3.2		A

Note: 1. Pulsed: Pulse duration = 300  $\mu s$ , duty cycle 1.5 %.  
 2. Pulse width limited by safe operating area.

## Safe Operating Area

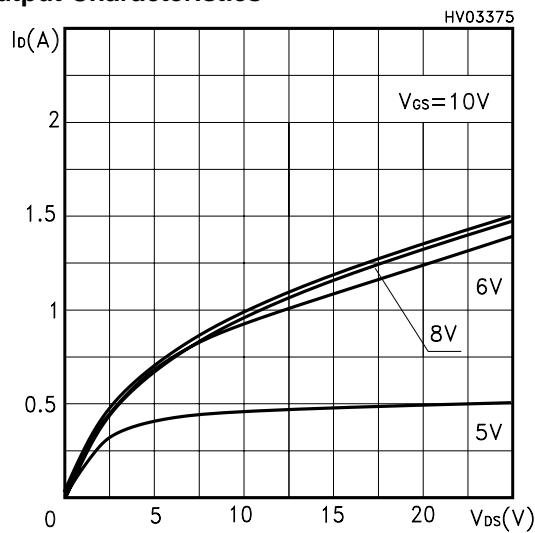


## Thermal Impedance

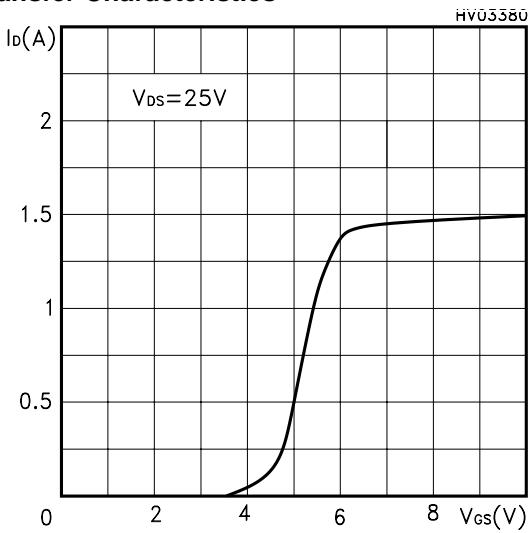


# STN1NC60

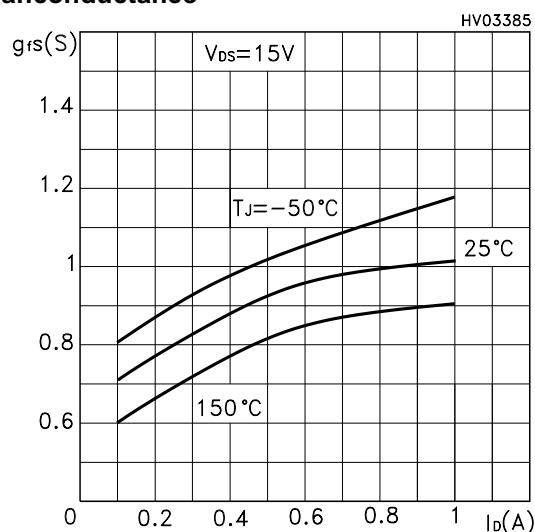
## Output Characteristics



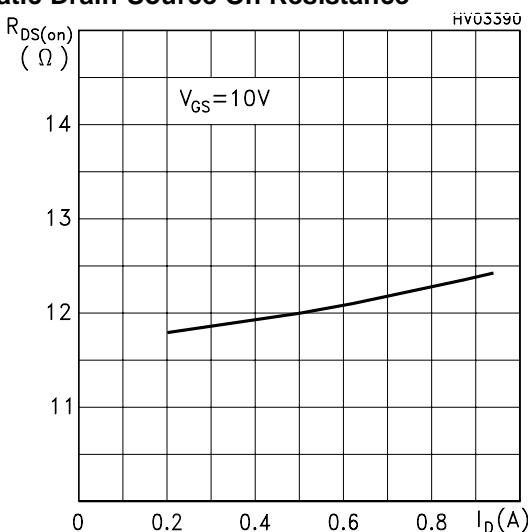
## Transfer Characteristics



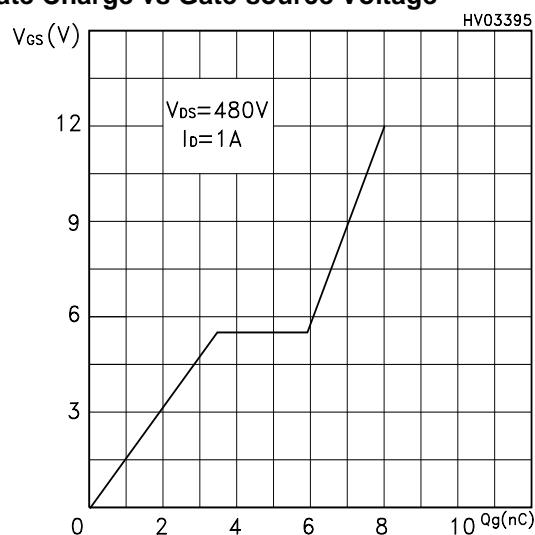
## Transconductance



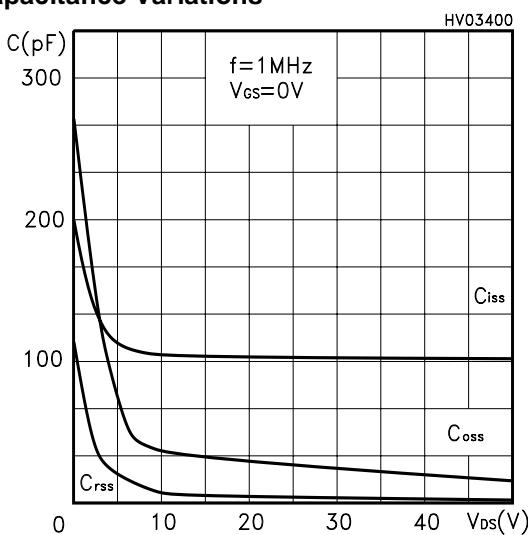
## Static Drain-Source On Resistance

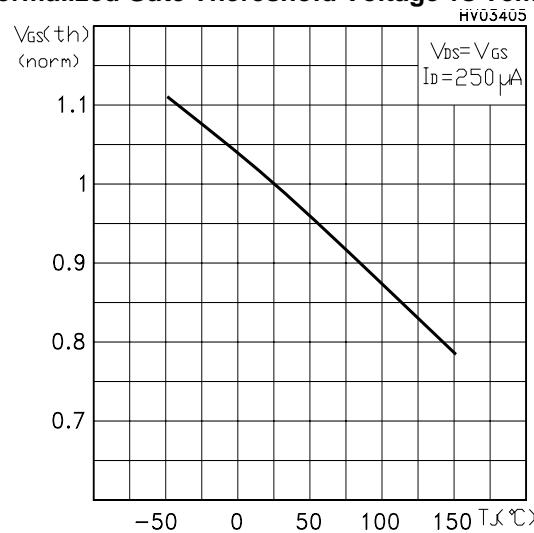
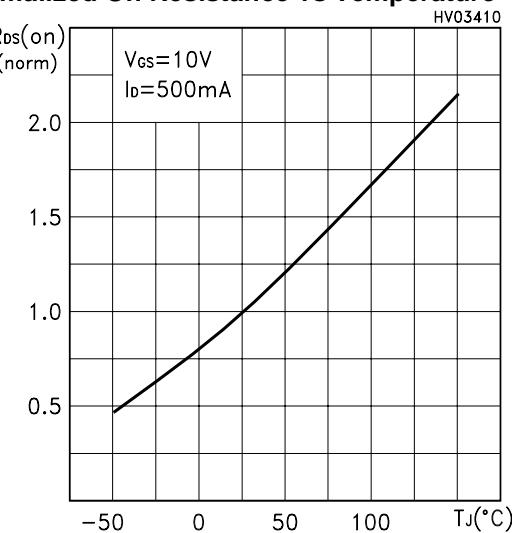
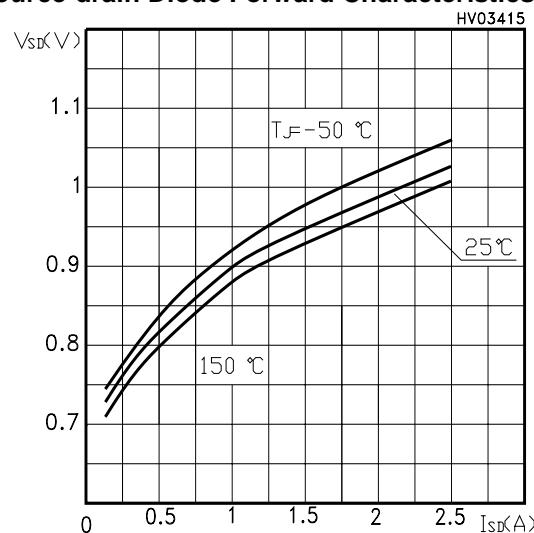


## Gate Charge vs Gate-source Voltage



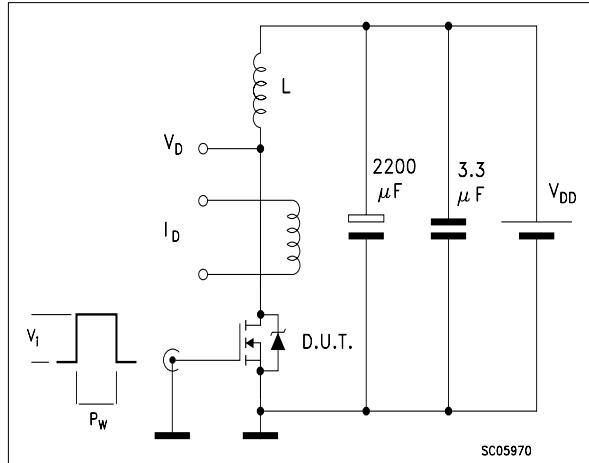
## Capacitance Variations



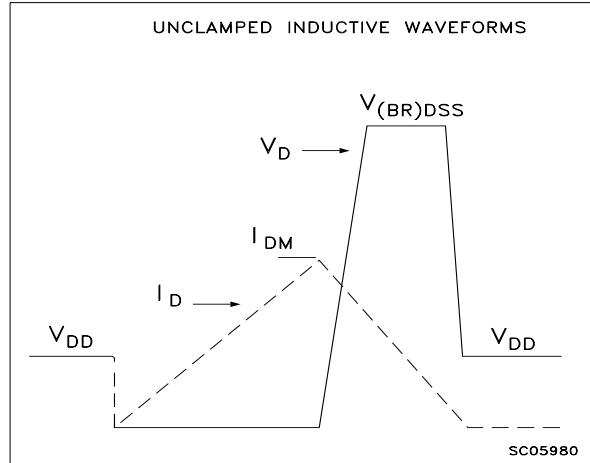
**Normalized Gate Threshold Voltage vs Temp.****Normalized On Resistance vs Temperature****Source-drain Diode Forward Characteristics**

## STN1NC60

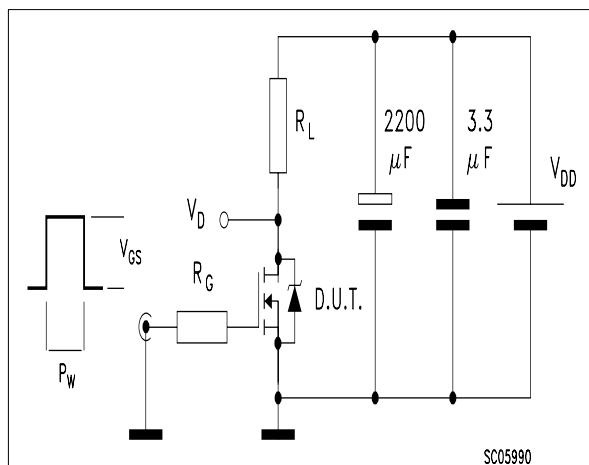
**Fig. 1:** Unclamped Inductive Load Test Circuit



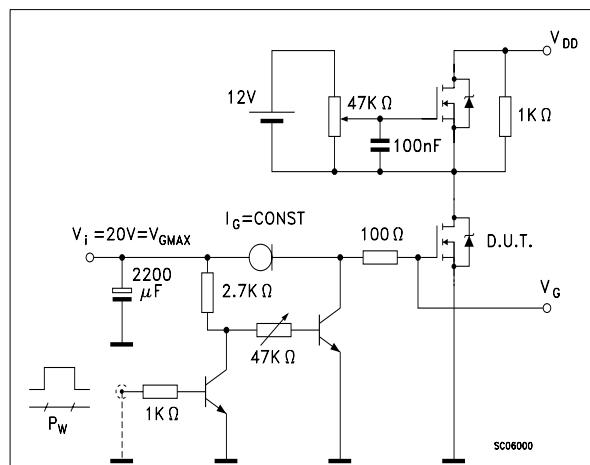
**Fig. 2:** Unclamped Inductive Waveform



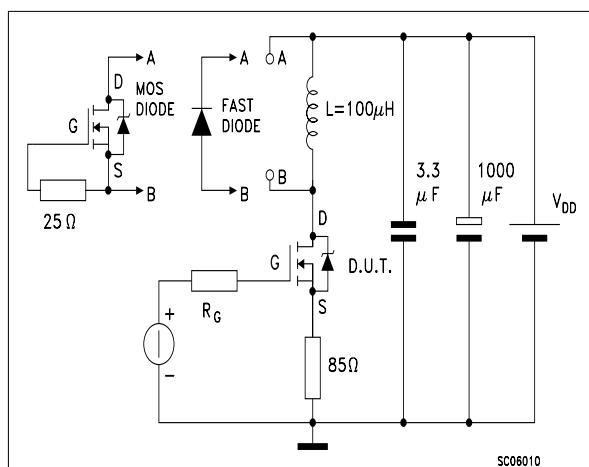
**Fig. 3:** Switching Times Test Circuits For Resistive Load



**Fig. 4:** Gate Charge test Circuit

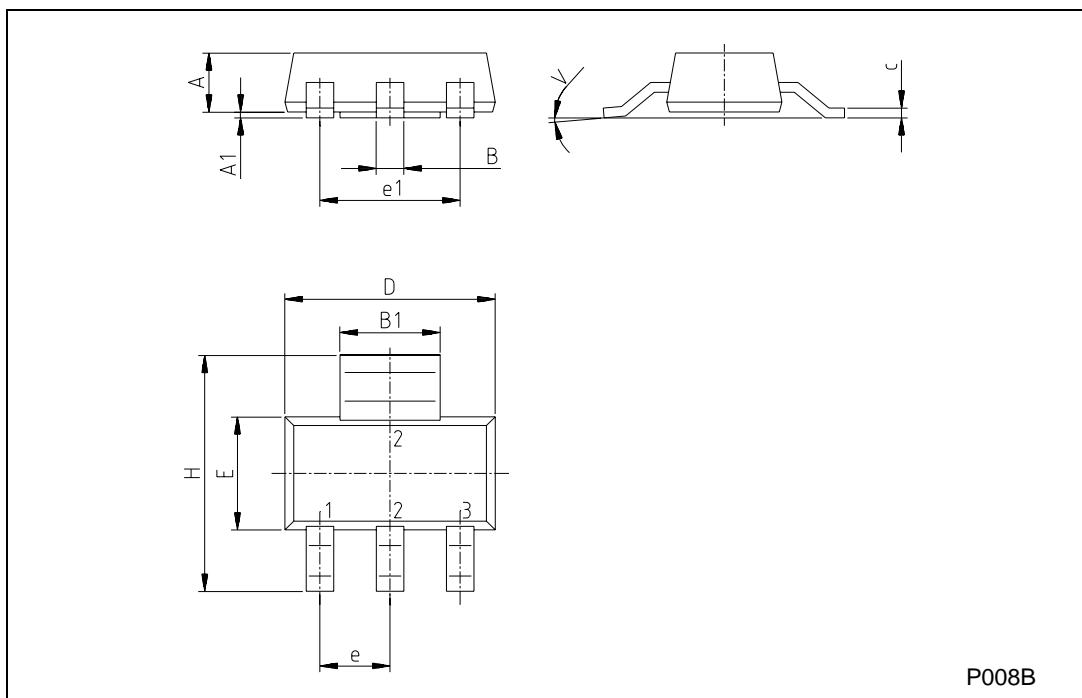


**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times



## SOT-223 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.80			0.071
B	0.60	0.70	0.80	0.024	0.027	0.031
B1	2.90	3.00	3.10	0.114	0.118	0.122
c	0.24	0.26	0.32	0.009	0.010	0.013
D	6.30	6.50	6.70	0.248	0.256	0.264
e		2.30			0.090	
e1		4.60			0.181	
E	3.30	3.50	3.70	0.130	0.138	0.146
H	6.70	7.00	7.30	0.264	0.276	0.287
V			10°			10°
A1		0.02				



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